

Hard X-ray Photoelectron Spectroscopy up to 14.5 keV on Au and C and $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$ Single Crystals

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Scientific Motivation

- Increase XPS Probe Depth
- High Energy Resolution in VB-Spectroscopy (High Resolution with Crystal Monochromators)
- Combination with Diffraction (e.g. X-ray Standing Wave Investigations on YBCO)

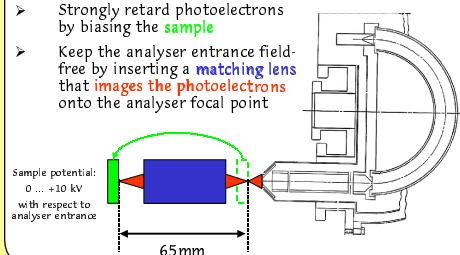
Experimental Motivation

- General**
- High monochrom. flux now available
- Possibility of focussing undulator radiation without too much loss
- Our Project**
- Get first experience with min. modification of equipment
- Obtain experimental cross sections for further planning
- Are Scofield-Tables (1973) useful here?
- Try Standing Wave research on YBCO

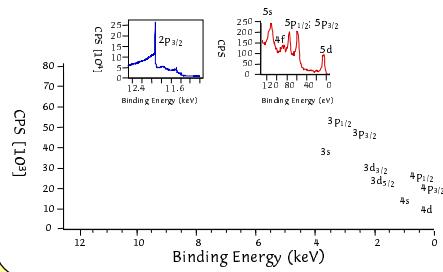
Modification of the PHI-Analyser

Idea:

- Strongly retard photoelectrons by biasing the sample
- Keep the analyser entrance field-free by inserting a matching lens that **images the photoelectrons** onto the analyser focal point

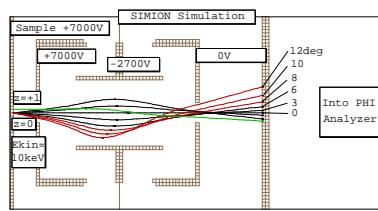


Continuous Spectrum of Au 2p to VB at $E_\gamma = 13.5$ keV

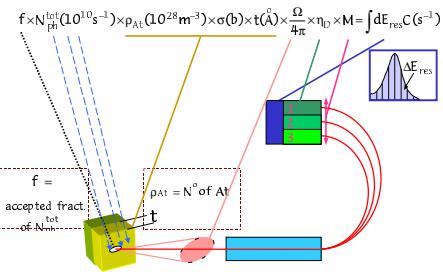


Lens Design with SIMION

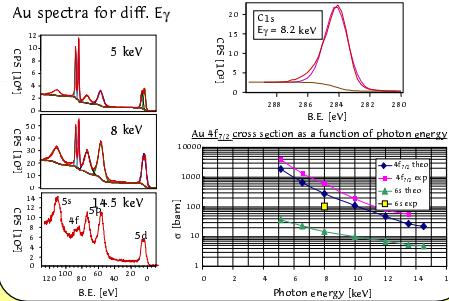
Modelling of the photoelectron path: Matching the electron emission solid angle and the source point size to the acceptance of the PHI analyser



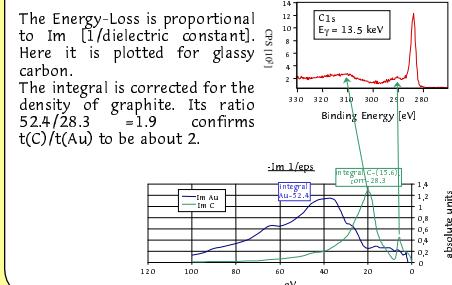
Total Counts in Sub-Level



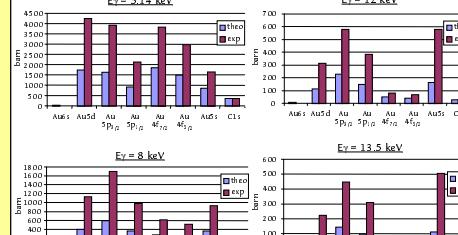
Determination of Cross Sections



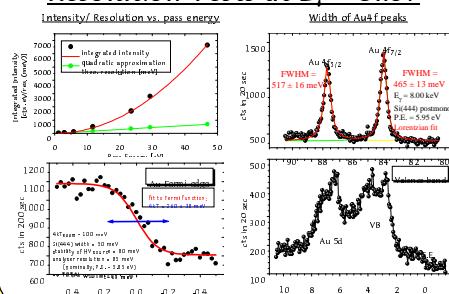
Energy-Loss Functions for Au and C



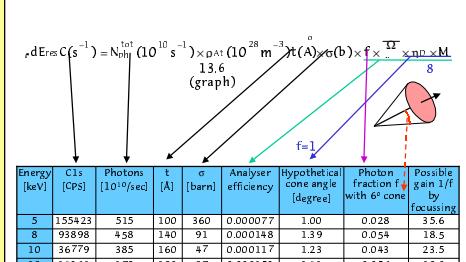
Experimental vs. Scofield H-F-S Cross Sections



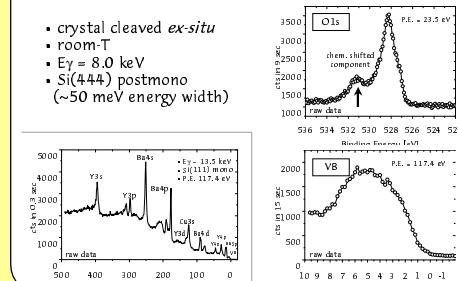
Resolution Tests at $E_\gamma = 8$ keV



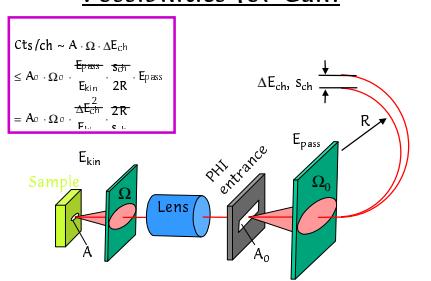
Efficiencies at Pass $E = 46.85$ eV



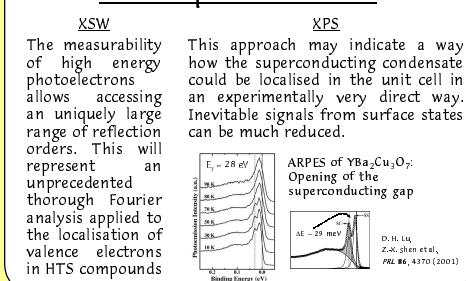
XPS on $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$ Single Crystal



Intensity Loss (Liouville) Possibilities for Gain



Outlook on XPS/ XSW with Superconductors



XSW
The measurability of high energy photoelectrons allows accessing an uniquely large range of reflection orders. This will represent an unprecedented thorough Fourier analysis applied to the localisation of valence electrons in HTS compounds.

XPS
This approach may indicate a way how the superconducting condensate could be localised in the unit cell in an experimentally very direct way. Inevitable signals from surface states can be much reduced.